

P-Channel 20-V (D-S) Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (m)(Typ.)	I _D (A)	Q _g (Typ.)	
- 20	24 at V _{GS} = - 4.5 V	- 7 ^a	17 nC	
	30 at V _{GS} = - 2.5 V			

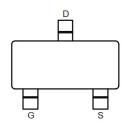
FEATURES

- DT-Trench Power MOSFET
- 100 % Rg and UIS Tested
- ESD Protected

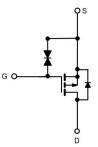
APPLICATIONS

- Portable Devices
 - Load Switch
 - Battery Switch





Top View



P-Channel MOSFET

ABSOLUTE MAXIMUM RATING	S T _A = 25 °C, unle	ss otherwise n	oted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 20	V		
Gate-Source Voltage		V _{GS}			± 8
	T _C = 25 °C		- 7 ^a		
Continuous Drain Current (T. = 150 °C)	T _C = 70 °C	I _D	- 5.8 ^a	1	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C		- 3 ^{b, c}	1	
	T _A = 70 °C		- 2.3 ^{b, c}	Α	
Pulsed Drain Current		I _{DM} - 21			
Continuous Source-Drain Diode Current	T _C = 25 °C	Î	- 5.5 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	- 2.5 ^{b, c}		
Maximum Power Dissipation	T _C = 25 °C	- P _D	6		
	T _C = 70 °C		3.9	w	
	T _A = 25 °C		1.6 ^{b, c}	7	
	T _A = 70 °C		1.05 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260	7	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, e}	t ≤ 5 s	R _{thJA}	40	60	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	5.5	6.5]	

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under Steady State conditions is 80 °C/W.

Rev.1.0



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$\Delta V_{DS}/T_J$ $I_D = -250 \mu A$		- 12			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 230 μΑ		3		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.3		- 1	V	
Cata Causa Laghara	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	±2		± 20		
Gate-Source Leakage		V _{DS} = 0 V, V _{GS} = ± 4.5 V			± 0.5		
7 O-1- V-11 D-1- O1		V _{DS} = - 20 V, V _{GS} = 0 V			- 1	μA	
Zero Gate Voltage Drain Current	DSS	V _{DS} = - 16 V, V _{GS} = 0 V, T _J = 55 °C			- 10	1	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 4.5 V	- 7			Α	
		V _{GS} = -4.5 V, I _D = -4 A		24	30		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -3 \text{ A}$		30	40	mΩ	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 4 A		10		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1318			
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		162		pF	
Reverse Transfer Capacitance	C _{rss}			141			
Total Gate Charge Q _g				17			
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4 \text{ A}$		2		nC	
Gate-Drain Charge	Q _{gd}			4			
Gate Resistance	R _g	f = 1 MHz		16		Ω	
Turn-On Delay Time	t _{d(on)}			9			
Rise Time	t _r	$V_{DD} = -10 \text{ V}, I_{D} = -4 \text{ A},$		30		nS	
Turn-Off Delay Time	t _{d(off)}	VGEN = - 4.5 V, Rg = 25 Ω		68			
Fall Time	t _f			20			
Drain-Source Body Diode Characterist	cs				_	<u> </u>	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 7		
Pulse Diode Forward Current	I _{SM}				- 21	A	
Body Diode Voltage	V _{SD}	I _S = -1 A, V _{GS} = 0 V		- 0.6	- 1	V	
Body Diode Reverse Recovery Time	t _{rr}	т		30		nS	
Body Diode Reverse Recovery Charge	Q _{rr}	- I _F = 4 A, dl/dt = 100 A/μs, T _J = 25 °C		20		nC	
Reverse Recovery Fall Time	t _a	1F - 4 A, αι/αι - 100 A/μs, 1J - 25 C		13		0	
Reverse Recovery Rise Time	t _b			17		nS	

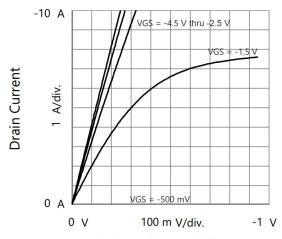
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

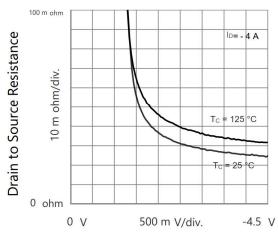
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

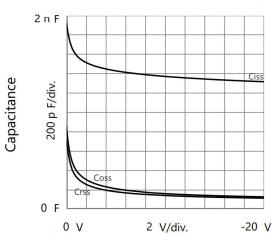


Drain to Source Voltage Output Characteristics

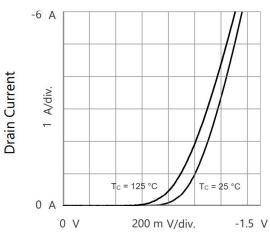


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

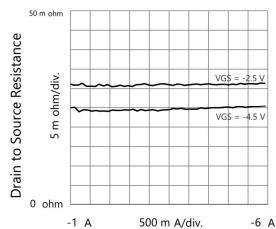
T_C = 125 °C

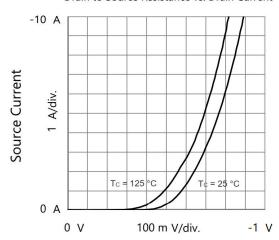


Drain to Source Voltage Capacitances



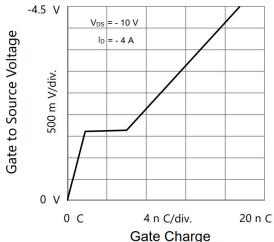
Gate to Source Voltage Transfer Characteristics



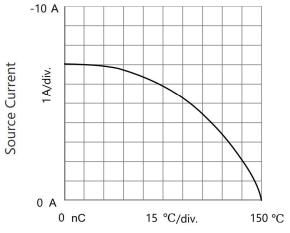


Source to Drain Voltage Body Diode Forward Characteristics

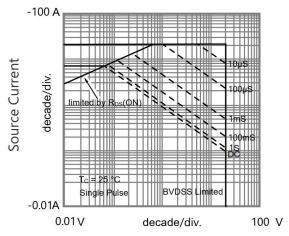
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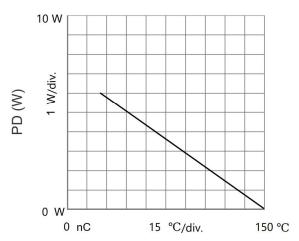
Gate Charge
Gate to Source Voltage vs. GateCharge



 T_{C} - Case Temperature $_{\text{Current Derating}}$



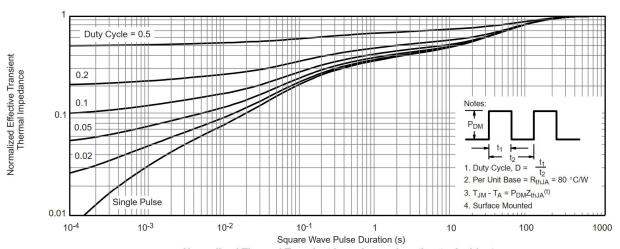
Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



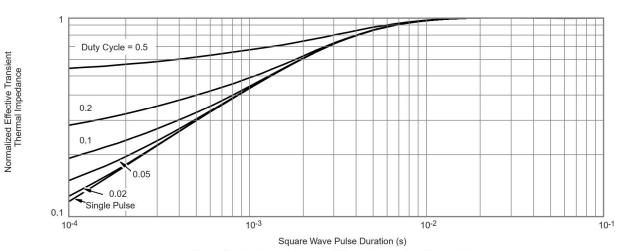
T_C - Case Temperature

Power Derating

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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